

Demystifying CMMI V2.0 - Article #1

From Pat OToole

Everyone,

Attached is the first article in my new series, “Demystifying CMMI V2.0” As mentioned in the article, I REALLY wanted to cover the new random sampling method used for CMMI V2.0 Benchmark and Sustainment appraisals, but felt that I couldn’t adequately address that topic without first speaking to the development and submission of the Project Inventory. So that’s the focus of Article #1; the sampling method will be the subject of Article #2.

For those of you totally unfamiliar with CMMI V2.0, you might find these 4 items particularly useful:

1. I have provided the full text of the Estimation (EST) practice area. This will give you an opportunity to look under the hood and see, at a low level, how the new model is constructed.
2. A higher level view of the model architecture is provided in the [ReadMe] tab of the Excel-based Project Inventory workbook. Although not referenced in the article, these two diagrams are provided to give you insight into Capability Areas and their associated Practice Areas AND to help you decode some of the new acronyms.
3. For a high level overview of “What Has Changed” with CMMI V2.0, you might want to take a look at this article by Neil Potter <http://processgroup.com/improvingcapability-and-performance-with-cmmi-v2-0-what-has-changed/>
4. Finally, Dave Greer is trying his best to reinvigorate the CMMI-Capability Maturity Model Integration (Main Group) LinkedIn group. <https://www.linkedin.com/groups/54046/> Stop in and either ask a burning question or take your best shot responding to someone else’s. Either way, you get more out of it if you put more in!

If anyone has any other good sources of CMMI V2.0-related information to convey, please let me know and I’ll consider putting it in the cover letter for future articles.

As mentioned in my chippy expectation-setting email – please don’t hesitate to send in questions, suggestions for future articles, or articles you’d like to write/co-author.

We are on this transitional journey together, and there is a ton we can learn from one another as we all move forward.

Regards,

Pat